

Instrumentation for micro-tomography experiments at BL20B2

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Measurement of CONVERSION GAIN for X-ray imaging detector

Measurement of the conversion gain helps us to understand sensitivity of X-ray detectors. In this practice, an X-ray detector which is composed of a beam monitor and a charged coupled device (CCD) camera is used. The incident X-ray beam onto the beam monitor is converted into visible light by a phosphor screen. The visible light image is focused on the CCD camera via relay lenses. The measurement procedure of the conversion gain is as follows.

I. Detection of incident X-ray beam using X-ray detector

You can use image acquisition software “HiPic” to view and analyze X-ray images.

- A) Adjust exposure time of the CCD camera so that adequate signals are obtained. Note that long exposure may induce saturation of signals.
- B) Adjust aperture size of a slit (TCslit1) using GUI on the X-terminal. In this case, X-ray beam size should be smaller than effective field of view of the X-ray detector.
- C) Measure the effective pixel size ($\mu\text{m}/\text{pixel}$) of the X-ray detector used.

II. Measurement of X-ray beam size

- A) Select “Rectangle ROI” from a tool bar on HiPic.
- B) Indicate the shape of the X-ray beam by ROI. The ROI size should be same as the X-ray beam size.
- C) Read out the ROI size in unit of pixel from “ROI interface” window. Then, actual X-ray beam size can be calculated from the ROI size and the effective pixel size.

III. Measurement of X-ray photon flux using ionization chamber.

- A) Measure intensity of the incident X-ray beam (I_0). You can read out the digitalized value from ORTEC Counter.
- B) In the same manner, measure the dark (background) signal (I_{dark}) without X-ray beam.
- C) Calculate real intensity by subtracting I_{dark} from I_0 .
- D) Convert the digitalized value into voltage. Here, you can use a conversion factor of a V/F converter; 1MHz/10Volts.
- E) Convert the voltage into ionization current generated in the ionization chamber. Here, you can use a gain factor of a current amplifier; $10^8\text{Volts}/1\text{Ampere}$. Actual gain factor is displayed in the current amplifier installed on beamline.
- F) Calculate X-ray photon flux using a following equation.

$$n(\text{photons / sec}) = \frac{W}{Ee} \cdot \frac{i}{1 - \exp(-\mu l)}$$

W : W-value of gas in the ionization chamber. In this case, it is air. $W_{air}=33.97\text{eV}$

E : Incident X-ray energy (eV)

e : Electrical charge; $1.602 \times 10^{-19}(\text{C})$

μ : Linear absorption coefficient (cm^{-1}) of air. See Table.

l : Length of electrode in the ionization chamber (cm).

i : Ionization current (A).

Table. 1 Linear absorption coefficient

X-ray energy (keV)	LAC of air (cm^{-1})
15	1.74×10^{-3}
20	8.07×10^{-4}
25	4.95×10^{-4}
30	3.65×10^{-4}

If you have derived the X-ray photon flux, let's calculate the X-ray photon flux per unit area (photons/sec/mm^2) using the X-ray beam size.

IV. Measurement of total amount of signals produced by X-ray detector

- A) Acquire an incident X-ray beam image. Remember that signals on the CCD camera should not be saturated. In the case of HiPic, a saturated pixel is represented as red color. Note the exposure time in order to estimate the total amount of signals per 1sec in the following calculation.
- B) Acquire a dark image with the same exposure time.
- C) Measure the total amount of signals (ADC_{total}) produced by the X-ray detector. Indicate the shape of the X-ray beam using a "rectangle ROI" tool. Here, the ROI size should be larger than the size of X-ray beam to capture all of signals. You can know the total amount of signals using an analytical tool on HiPic. Find "Analysis" located at a menu bar on HiPic and select "Histogram display". Then, you will obtain the total amount of signals (Total count) by pushing "Get histogram" button.
- D) In the same manner, measure the total amount of dark signals (ADC_{dark}) at the same ROI position.
- E) Calculate the real signal by subtracting ADC_{dark} from ADC_{total} .
- F) Convert the real signal calculated above into the total amount of signals per 1sec (ADC_{sec}) by considering the exposure time.

V. Calculation of conversion gain for X-ray detector

- A) The conversion gain (ADC_{photon}), which is the amount of signals generated by a single X-ray photon, will be calculated by dividing the total amount of signals per 1sec (ADC_{sec}) by the incident X-ray photon flux (photons/sec).